To Whom It May Concern
Domestic Tender to supply Scrubber System by local vendor only

This is an RFQ (Request for Quote) for procurement of an ICP-RIE system as part of a domestic tender for the Centre for Nano Science and Engineering (CeNSE) at IISc, Bangalore. The tender invitation is for Indian Original Equipment Manufacturer (OEM)/Class-1/Class-2 or their Indian authorized distributor only.

CeNSE is a multidisciplinary research department at IISc that houses a 14,000 sq. ft. cleanroom and characterization facility used by 50 faculty members from various disciplines at IISc. CeNSE also runs a program called Indian Nanoelectronics Users Program (INUP) which has allowed 4200 participants from more than 700 universities and institutes all over India to use the facilities at CeNSE. Consequently, any tool in CeNSE receives significant exposure to scientific community at IISc and beyond. The vendors are requested to factor in the value of this exposure in to their quotes. Details of existing facilities and INUP program can be gleaned from:
http://nnfc.cense.iisc.ac.in/
http://www.mnncf.cense.iisc.ac.in/
https://www.inup.cense.iisc.ac.in/

Also, CeNSE hosts equipment on behalf of vendors, as a national standard or ‘model’ system. If the vendor is interested, CeNSE can consider working out a similar arrangement for the ICP-RIE system.

Procedure
1. Vendors will be required to submit a technical proposal and a commercial proposal in two separate sealed envelopes. Only vendors who meet the technical requirement will be considered for the commercial negotiation.
2. The deadline for submission of proposals is 8th July 2022 5:30 pm Indian Standard Time. Proposals should arrive at the Main office, GF-15, Centre for Nano Science and Engineering, Indian Institute of Science, Bangalore 560012, India, by the above deadline.
3. The decision of purchase committee will be final.
4. The technical proposal should contain a compliance table with 5 columns. The first column must list the technical requirements, in the order that they are given in the technical configuration below. The second column should describe your compliance in a “Yes” or “No” response. If “No” the third column should provide the extent of the deviation (please provide quantitative responses). The fourth column should state the reasons for the deviation, if any. The fourth column can be used to compare your tool with that of your competitors or provide details as requested in the technical requirements table below.
5. Any additional capabilities or technical details, that you would like to bring to the attention of the purchase committee, can be listed at the end of the technical table.
6. Vendors are encouraged to highlight the advantages of their tools over comparable tools from the competitors.
7. If multiple systems can fulfill the requirements, vendors can submit multiple bids.
8. In the commercial bid, please provide itemized cost of the system and required accessories, such as software, power supply, etc.
9. As an option, please provide itemized cost for any suggested accessories/add-ons that may enhance the usability, capability, accuracy or reliability of the tool. Vendors are encouraged to quote for as many add-ons as their tool portfolio permits.
10. The commercial comparison will be done as per Government of India rules, specifically GFR 2017. Note that GFR has recently been amended.
11. As per recent edits to the GFR, there are three classes of vendors distinguished by their “local content”. In the cover letter, vendors must mention which applies to them:
   - Class 1 supplier: Goods and services have a local content of equal to or more than 50%
   - Class 2 supplier: Goods and services have a local content more than 20% but less than 50%
   - Non-local supplier: Goods and services have a local content of equal to or less than 20%.
   Quotes will be entertained from Class 1 or Class 2 suppliers only.
12. Please indicate the warranty provided with the tool. Warranty of 3 years or more is preferred.
13. The quotations should be on FOR-IISc Bangalore basis in INR only.
14. Provide itemized cost for required spares for 2 years of operation. For sake of this calculation, the vendor may assume active tool usage of 20 hours/week. This number will be used to estimate the life cycle cost of the tool.
15. Clarify if periodic (preventive) maintenance be done by a trained on-site engineer or requires a specialist from the OEM.
16. If maintenance requires OEM, as an additional option, provide cost of an annual maintenance contract (AMC) for 3 years, post warranty. The AMC cost must also include an itemized list of spares that are essential for the scheduled visits.
17. The RFQ must include references of 3 previous installations, preferable in India. Please provide the names and contact addresses of the referees, so that the committee can contact them independently.
18. Any questions can be directed to Dr. Savitha P, GF-20, Centre for Nano Science and Engineering, Indian Institute of Science, Bangalore 560012, India. (savithap@iisc.ac.in)
## Technical Requirements

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| **1. Primary application** | • ICP-RIE for ETCH the following materials:  
  • Gallium Nitride, Gallium oxide, Al, Ti, Cr, W  
  • Resist/Polymer Ashing  
  • Must conform to some SEMI standard for ICP equipment manufacturing,  
    e.g. SEMI SEMI E6-0914, SEMI E15-0698E2, SEMI S21-1106E, SEMI S19-0311 (Reapproved 0816), etc. |
| **2. Secondary application** | • Etch SiO2 and Si3N4  
  • Shallow etches of Silicon (~100 micrometers) |
| **3. Process capability** | • Etching substrates and thin films with a surface non-uniformity of <5% within wafer and <3% wafer to wafer, with surface roughness <2nm  
  • Etching capability down to less than 50nm feature size  
  • Ability to use both F2 and Cl2 based chemistries in the same chamber  
  • Ability to use sputter etches using Ar  
  • Anisotropic etch profile  
  • Please specify the highest aspect ratio that can be achieved  
  • Provide detailed technical literature for the system use, such as your prior experience and technical data on etch processes and tool capabilities |
| **4. Process recipes** | • At the time of installation, all standard process recipes should be provided |
| **5. Substrate details** | • Processing of up to 6 inch wafers  
  • However, we need suitable substrate adapters to process 4 inch, 3 inch, 2 inch and cut pieces of substrates measuring more than 2cmx2cm  
  • Should be able to handle substrates other than Si, like Alumina, SiC, GaAs |
| **6. Tool requirements** | • Load lock chamber : software controlled load and unload options  
  • Wider matching network  
  • The roughing vacuum pump for main chamber and load lock chamber should be dry pumps with appropriate pumping capacity. Turbomolecular pump with appropriate capacity for ensuring the required process vacuum.  
  • He substrate cooling  
  • Ability to change liners easily to prevent cross contamination |
| **7. Substrate temperature** | • Option to heat up to 200°C. If this is an additional requirement, itemize cost |
| **8. Power level** | • Typical RF Power range 100W - 600W, with automatic power matching unit and with an option to bias the substrate (typical range of 100W - 600W)  
  • ICP power in the range of 600-2000W |
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| 9. | Chuck configuration | • Manual chuck with the provision to handle 6 inch wafers  
• Provision to use wafers of 4 inch, 3 inch etc |
| 10 | End point detection | • Give all the options available, itemize cost |
| 11 | Process gases lines required | O₂, Ar, N₂, H₂, Cl₂, BCl₃, CH₄, HBr, SF₆, CHF₃, C₄F₈ (11 lines) + one additional line |
| 12 | Gas Manifold | Gas manifold should have 12 lines.  
• MFCs need to be installed only for the lines and gases specified. All the lines should have swagelok VCR fittings and welding if any should be orbital welding. The lines should be SS316L electro-polished suitable for corrosive and non-corrosive gases used for the specific process. MFCs should be MKS make. |
| 13 | Footprint & weight | • The system should compatible with better than class 1000 cleanroom environment. Please specify the total foot print in cm x cm, and weight. |
| 14 | Process software | • Front panel displaying equipment and process status along with appropriate software to be supplied.  
• The software must allow varying levels of instrument access. A simplified basic access for a user to a full access to an engineer.  
• Interlock that can interface with the online reservation system, so that the tools can only be used by authorized users.  
• Complete logs of all the process and system parameters to be available and stored for future trouble shooting  
• Graphical representation of tool and process parameters  
• Provision to alert the user in case of emergencies and an option to integrate the alarm system to NNFC building monitoring software  
• Software need to be supported for the lifetime of the tool |
| 15 | Periodic Maintenance | • The system should require minimal maintenance.  
• Mention the recommended preventive maintenance schedule for the system. Any accessories needed for periodic preventive maintenance for 3 years e.g. O-rings, should be mentioned in separately the itemized quote.  
• Can the preventive maintenance be done by a trained on-site engineer or requires a specialist from the OEM? If the latter, please provide cost of a 3 year AMC with required kit/consumables.  
• The system should be supported by a trained representative and should have a 48-hour window of response |
| 16 | Installation and Training | • Installation and training at customer site, by the experts from principals should be part of the package.  
• During the installation all the specifications of the processes should be verified for acceptance by the customer. |
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<td><strong>Power &amp; utilities</strong></td>
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<td>• The instrument should work with Indian standards</td>
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<td>• Mention the power requirement.</td>
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<td>• Mention any utility requirement (water, air, exhaust, etc.)</td>
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<td><strong>Safety</strong></td>
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<td>• Mention any special safety requirement of the tool</td>
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<td>• The tool must come with a complement of interlocks to prevent common user errors.</td>
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<td>• Sensors should be provided to detect ppb levels of gas leaks and utility failures including scrubber failure</td>
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<td>• Any malfunction should have an audible alarm system.</td>
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<td>• Flashing lights during emergencies should also be an option</td>
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<td><strong>Recommendation</strong></td>
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<td>• The system must submit references from at least 3 previous installations etching similar type of materials as specified in Row 1 in a semiconductor of similar size as NNFC or bigger</td>
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<td>• The names and contact addresses of the referees must be submitted with the proposal, so the purchase committee can contact them independently.</td>
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<td><strong>Pre-purchase testing</strong></td>
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<td>• To ensure the equipment conforms for specifications, the committee requires the vendor to perform some standard tests before the purchase process is complete. The validity of the tender will hinge on the successful and accurate measurement of these test samples.</td>
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<td>• The vendor must conclude the testing and submit the data within 1 week of receipt of samples.</td>
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<td><strong>Acceptance tests</strong></td>
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<td>• Performing mesa etch on GaN</td>
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<td>• Etching 100nm Al layer with high selectivity to photoresist</td>
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<td>• Etching 50nm wide trenches in SiO2 on Si to the highest aspect ratios possible and with high selectivity to Si</td>
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<td>• Demonstrate working of all the accessories including endpoint detector.</td>
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Thanking you,

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